## Notice of References Cited .

	Application/Control No. 10/622,776	Reexaminatio	Applicant(s)/Patent Under Reexamination HAGANO ET AL.		
į	Examiner	Art Unit			
	Kallambella Vijayakumar	1751	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-6,605,665	08-2003	Fischer et al.	524/504	
*	В	US-6,164,482	12-2000	Araki et al.	220/375	
*	С	US-5,992,669	11-1999	Hagano et al.	220/288	
*	D	US-5,373,039	12-1994	Sakai et al. 524/100		
*	E	US-5,409,775	04-1995	Harada et al.	428/367	
*	F	US-5,262,470	11-1993	Shimotsuma et al.	524/496	
*	G	US-2003/0021926	01-2003	Springholz et al.	428/36.1	
	Н	US-				
	1	US-				
	j	US-				
	К	US-				
	L	US-				
	М	US-				

## **FOREIGN PATENT DOCUMENTS**

		<del></del>	<del></del>			
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	DE 10013000	09-2001	DE	Springholtz et al	B65D 1/02
	0					
	Ρ					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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